

<b>Notice of References Cited</b>	Application/Control No. 10/690,160	Applicant(s)/Patent Under Reexamination RILEY ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"Range antenna pattern measurements of airborne SAR system with arrayed corner reflectors", Satake et al, Proceedings of IEEE International Geoscience and Remote Sensing Symposium. IGARSS 2002, vol.2, Toronto, Ont., Canada, 24-28 June 2002., p.859-61.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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